## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination LUCAS ET AL. | Examiner | Art Unit | Page 1 of 1 U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2003/0000109 A1	01-2003	Kita, Kenjiro	36/30.00R
	В	US-5,367,792 A	11-1994	Richard et al.	36/114
П	С	US-4,498,251	02-1985	Shin, Yoon K.	36/30R
	D	US-4,535,553	08-1985	Derderian et al.	36/28
П	Е	US-4,624,061	11-1986	Wezel et al.	36/30A
	F	US-4,754,559	07-1988	Cohen, Eli	36/3B
	G	US-5,195,256 A	03-1993	Kim, Sang D.	36/27
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	P.					
	Q					
	R					
	S				•	
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	•
	U		
	<b>V</b>		
	W		
	х		

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.